

Search Notes

Application/Control No.

10/849,257

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

SHIBATA ET AL.

Art Unit

2874

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 385 | 129-132 | 12/20/2005 | JDS |
| 359 | 846 | 12/20/2005 | JDS |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|------------|------|
| See attached EAST search history | 12/20/2005 | JDS |
| IEEE and INSPEC | 12/20/2005 | JDS |
| Reviewed International Search Report and Written Opinion of corresponding International Application PCT/ JP04/007209 | 12/20/2005 | JDS |
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